

Notice of References Cited	Application/Control No. 10/748,308	Applicant(s)/Patent Under Reexamination WON ET AL.	
	Examiner Thinh T. Nguyen	Art Unit 2818	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0096473	05-2003	Shih et al.	438/240
	B	US-2004/0067657	04-2004	Perng et al.	438/745
	C	US-6,576,053	06-2003	Kim et al.	117/89
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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